

## BA157 - BA159 FAST RECOVERY RECTIFIER DIODES

VOLTAGE RANGE: 400 - 1000V CURRENT: 1.0 A

## **Features**

Diffused Junction

Low Forward Voltage Drop

High Current Capability

High Reliability

High Surge Current Capability

## **Mechanical Data**

Case: D O - 4 1 Molded Plastic

Terminals: Plated Leads Solderable per

MIL-STD-202, Method 208

Polarity: Cathode Band

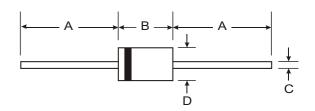
Weight: 0.34 grams (approx.)

Mounting Position: AnyMarking: Type Number

RoHS

COMPLIANT





DO-41					
Dim	Min	Max			
Α	25.40	_			
В	4.06	5.21			
С	0.71	0.864			
D	2.00	2.72			
All Dimensions in mm					

## Maximum Ratings and Electrical Characteristics T<sub>A</sub> = 25°C unless otherwise specified

Single phase, half wave, 60Hz, resistive or inductive load. For capacitive load, derate current by 20%.

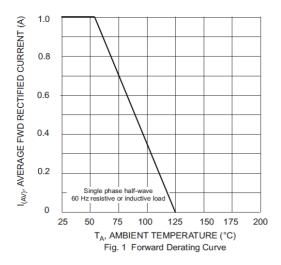
Characteristic	Symbol	BA157	BA158	BA159	Unit
Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	VRRM VRWM VR	400	600	1000	V
RMS Reverse Voltage	VR(RMS)	280	420	700	V
Average Rectified Output Current (Note 1) @T <sub>A</sub> = 55°C	lo	1.0			А
Non-Repetitive Peak Forward Surge Current 8.3ms Single half sine-wave superimposed on rated load (JEDEC Method)	Ігѕм	30		А	
Forward Voltage @I <sub>F</sub> = 1.0A	VFM	1.2		V	
Peak Reverse Current $@T_A = 25^{\circ}C$ At Rated DC Blocking Voltage $@T_A = 100^{\circ}C$	IRM	5.0 100		μA	
Reverse Recovery Time (Note 2)	trr	150	250	500	nS
Typical Junction Capacitance (Note 3)	Cj	15		pF	
Operating Temperature Range	Tj	-65 to +125		°C	
Storage Temperature Range	Тѕтс	-65 to +150		°C	

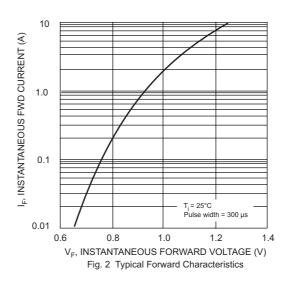
Note: 1. Leads maintained at ambient temperature at a distance of 9.5mm from the case

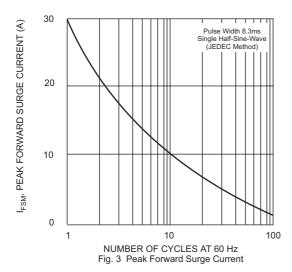
2. Measured with IF = 0.5A, IR = 1.0A, IRR = 0.25A. See figure 5.

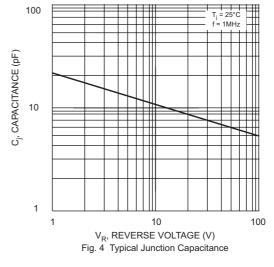
3. Measured at 1.0 MHz and applied reverse voltage of 4.0V D.C.

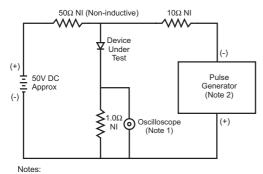


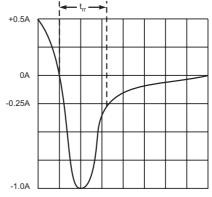












Set time base for 5/10ns/cm

1. Rise Time = 7.0ns max. Input Impedance =  $1.0M\Omega$ , 22pF. 2. Rise Time = 10ns max. Input Impedance =  $50\Omega$ .

Fig. 5 Reverse Recovery Time Characteristic and Test Circuit